Application/Control No. Applicant(s)/Patent Under Reexamination 10/773,315 KURODA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2816 Hai L. Nguyen **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY * 07-2002 327/295 US-6,426,662 B1 Arcus, Christopher G. Α US-В US-С US-D US-Ε US-F US-G US-Н US-US-J Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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